

# UNISONIC TECHNOLOGIES CO., LTD

5N65 Power MOSFET

# 5A, 650V N-CHANNEL **POWER MOSFET**

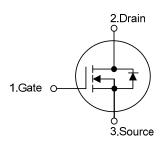
#### DESCRIPTION

The UTC 5N65 is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications at power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

#### **FEATURES**

- \*  $R_{DS(ON)}$  < 2.4 $\Omega$  @ $V_{GS}$  = 10 V
- \* Ultra Low Gate Charge (Typical 15 nC)
- \* Low Reverse Transfer Capacitance ( C<sub>RSS</sub> = Typical 6.5 pF )
- \* Fast Switching Capability
- \* Avalanche Energy Specified
- \* Improved dv/dt Capability, High Ruggedness0

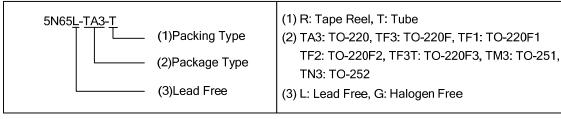
#### **SYMBOL**

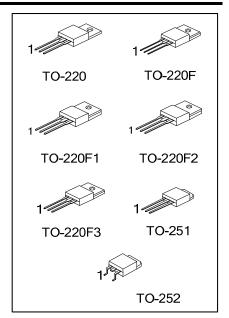


### ORDERING INFORMATION

Ordering Number		Daakaga	Pin Assignment			Packing	
Lead Free	Halogen Free	Package	1	2	3	Facking	
5N65L-TA3-T	5N65G-TA3-T	TO-220	G	D	S	Tube	
5N65L-TF3-T	5N65G-TF3-T	TO-220F	G	D	S	Tube	
5N65L-TF1-T	5N65G-TF1-T	TO-220F1	G	D	S	Tube	
5N65L-TF2-T	5N65G-TF2-T	TO-220F2	G	D	S	Tube	
5N65L-TF3T-T	5N65G-TF3T-T	TO-220F3	G	D	S	Tube	
5N65L-TM3-T	5N65G-TM3-T	TO-251	G	D	S	Tube	
5N65L-TN3-R	5N65G-TN3-R	TO-252	G	D	S	Tape Reel	

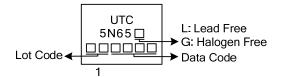
Note: Pin Assignment: G: Gate D: Drain S: Source





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# ■ MARKING



# ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> = 25°C, unless otherwise specified)

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PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{DSS}$	650	V	
Gate-Source Voltage		$V_{GSS}$	±30	V	
Avalanche Current (Note 2)		$I_{AR}$	5	Α	
Continuous Drain Current		$I_{D}$	5	Α	
Pulsed Drain Current (Note 2)		$I_{DM}$	20	Α	
Avalanche Energy	Single Pulsed (Note 3)	$E_{AS}$	210	mJ	
	Repetitive (Note 2)	$E_{AR}$	10		
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns	
Power Dissipation	TO-220		100		
	TO-220F/TO-220F1	P <sub>D</sub>	20	147	
	TO-220F2/TO-220F3		36	W	
	TO-251/TO-252		54		
Junction Temperature		TJ	+150	°C	
Operation Temperature		$T_OPR$	-55 ~ <b>+</b> 150	°C	
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Pulse width limited by  $T_{J(MAX)}$
- 3. L = 16.8mH,  $I_{AS}$  = 5A,  $V_{DD}$  = 50V,  $R_{G}$  = 25  $\Omega$ , Starting  $T_{J}$  = 25°C
- 4.  $I_{SD} \le 5A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$

#### **■ THERMAL DATA**

PARAMETE <u>R</u>		SYMBOL	RATINGS	UNIT	
Junction to Ambient	TO-220		62.5	°C/W	
	TO-220F/TO-220F1 TO-220F2/TO-220F3	$\theta_{JA}$	62.5		
	TO-251 / TO-252		160		
Junction to Case	TO-220		1.25		
	TO-220F/TO-220F1 TO-220F2/TO-220F3	$\theta_{JC}$	3.47	°C/W	
	TO-251 / TO-252		2.3		

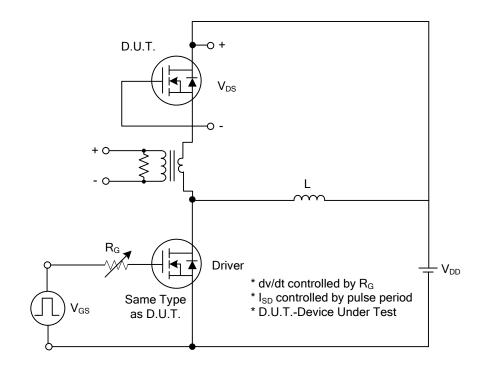
# ■ **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	$V_{GS} = 0V, I_D = 250\mu A$ 6				V
Drain-Source Leakage Current	I <sub>DSS</sub>	$V_{DS} = 650 V, V_{GS} = 0 V$			1	μΑ
Coto Source Leekage Current Forward	<u> </u>	$V_{GS} = 30V, V_{DS} = 0V$			100	<b></b> Λ
Gate-Source Leakage Current Reverse	e I <sub>GSS</sub>	$V_{GS} = -30V, V_{DS} = 0V$			-100	nA
Breakdown Voltage Temperature Coefficie	ent ∆BV <sub>DSS</sub> /∆T <sub>J</sub>	I <sub>D</sub> =250μA, Referenced to 25℃		0.6		V/°C
ON CHARACTERISTICS					=.	
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$			4.0	V
Static Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	$V_{GS} = 10V, I_D = 2.5A$		2.0	2.4	Ω
DYNAMIC CHARACTERISTICS						
Input Capacitance	C <sub>ISS</sub>	), OF), ), O),		515	670	pF
Output Capacitance	Coss	$V_{DS} = 25V, V_{GS} = 0V,$ f = 1.0MHz		55	72	pF
Reverse Transfer Capacitance	$C_{RSS}$	I = 1.0MHZ		6.5	8.5	pF
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t <sub>D(ON)</sub>			10	30	ns
Turn-On Rise Time	t <sub>R</sub>	$V_{DD} = 325V, I_D = 5A,$		42	90	ns
Turn-Off Delay Time	t <sub>D(OFF)</sub>	$R_G = 25\Omega \text{ (Note 1, 2)}$		38	85	ns
Turn-Off Fall Time	t <sub>F</sub>	]		46	100	ns
Total Gate Charge	$Q_G$	V - 520 V I - 54		15	19	nC
Gate-Source Charge	$Q_GS$	V <sub>DS</sub> = 520 V, I <sub>D</sub> = 5A, V <sub>GS</sub> = 10 V (Note 1, 2)		2.5		nC
Gate-Drain Charge	$Q_GD$	V <sub>GS</sub> = 10 V (Note 1, 2)		6.6		nC
DRAIN-SOURCE DIODE CHARACTERIS	TICS AND MAXII	MUM RATINGS			-	
Drain-Source Diode Forward Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V}, I_{S} = 5A$			1.4	V
Maximum Continuous Drain-Source Diode	) l <sub>-</sub>				5	Α
Forward Current	I <sub>S</sub>				Ü	А
Maximum Pulsed Drain-Source Diode	lou				20	Α
Forward Current	I <sub>SM</sub>				20	^
Reverse Recovery Time	t <sub>rr</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> =5A, 300			ns	
Reverse Recovery Charge	$Q_{RR}$	d <sub>IF</sub> / dt = 100 A/μs (Note 1)		2.2		μC

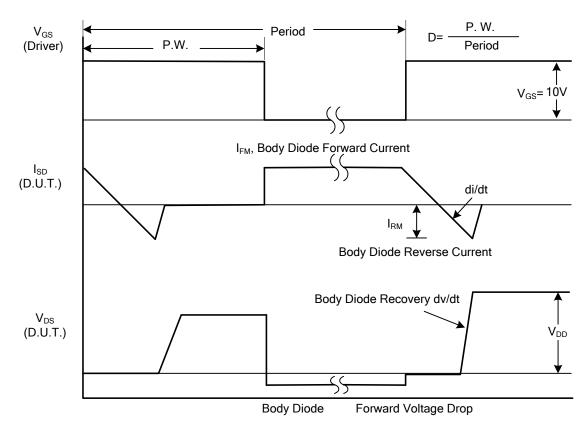
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

<sup>2.</sup> Essentially independent of operating temperature

#### ■ TEST CIRCUITS AND WAVEFORMS

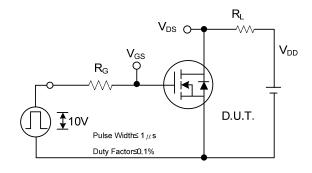


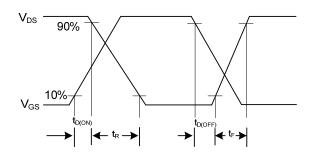
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

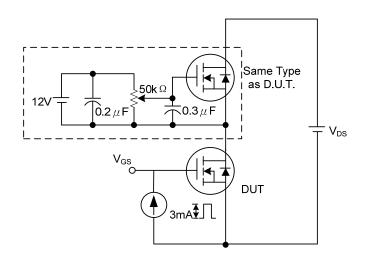
# ■ TEST CIRCUITS AND WAVEFORMS (Cont.)

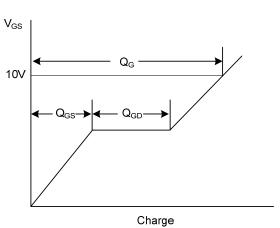




**Switching Test Circuit** 

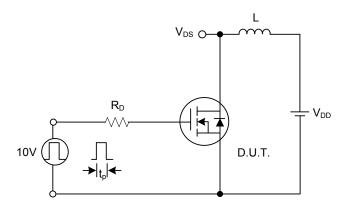
**Switching Waveforms** 

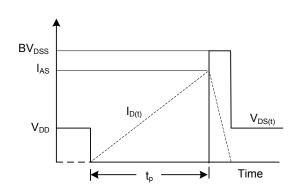




**Gate Charge Test Circuit** 

**Gate Charge Waveform** 

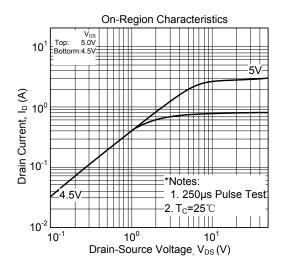


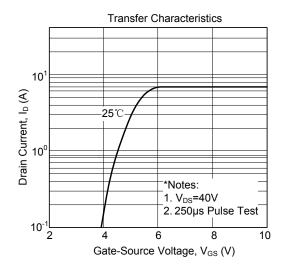


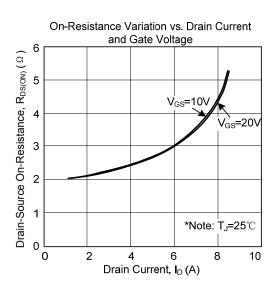
**Unclamped Inductive Switching Test Circuit** 

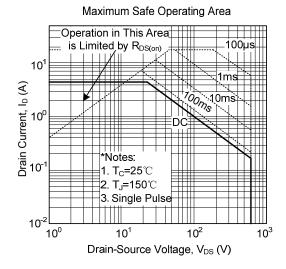
**Unclamped Inductive Switching Waveforms** 

#### ■ TYPICAL CHARACTERISTICS









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